


<b>Search Notes</b>  	<b>Application/Control No.</b>  10567474	<b>Applicant(s)/Patent Under Reexamination</b>  MICHL, ANDREAS
	<b>Examiner</b>  JAE Y LEE	<b>Art Unit</b>  2419

SEARCHED			
Class	Subclass	Date	Examiner
370	241,252,474	9/11/2008	Jae Y Lee

SEARCH NOTES		
Search Notes	Date	Examiner
service access point, SAP, OSI, analyze, monitor, sniffer, mobile	9/11/2008	Jae Y Lee
Limited search using class/subclass 370/241,252,474	9/11/2008	Jae Y Lee
Inventor search: Andreas Michl	9/11/2008	Jae Y Lee
NPL search using the terms: service access point, SAP, OSI, analyze, monitor, sniffer, mobileby Google	9/11/2008	Jae Y Lee
Consulted with primary examiner Steven H. Nguyen	9/11/2008	Jae Y Lee

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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